

Notice of References Cited		Application/Control No. 10/646,575	Applicant(s)/Patent Under Reexamination WU ET AL.	
		Examiner USMAAN SAEED	Art Unit 2166	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,463,754 A	10-1995	Beausoleil et al.	709/213
*	B US-5,689,697 A	11-1997	Edwards et al.	1/1
*	C US-2002/0049778 A1	04-2002	Bell et al.	707/200
*	D US-2002/0116373 A1	08-2002	Nishikawa et al.	707/3
*	E US-6,463,509 B1	10-2002	Teoman et al.	711/137
*	F US-2003/0033303 A1	02-2003	Collins, Brian	707/9
*	G US-2003/0037056 A1	02-2003	Sedlar, Eric	707/100
*	H US-2003/0204536 A1	10-2003	Keskar et al.	707/200
*	I US-6,654,794 B1	11-2003	French, Steven Michael	709/217
*	J US-7,499,925 B2	03-2009	Moore et al.	1/1
*	K US-7,523,127 B2	04-2009	Chen-Wright et al.	1/1
*	L US-7,831,548 B1	11-2010	Round et al.	707/609
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
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X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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